

**Search Notes**

Application/Control No.

10/045,810

Examiner

Erin M. File

Applicant(s)/Patent under  
Reexamination

SEDAT OELCER

Art Unit

2634

**SEARCHED**

Class	Subclass	Date	Examiner
332	144	3/27/2005	EMF
370	215	3/27/2005	EMF
375	259	3/27/2005	EMF
375	260	3/27/2005	EMF
375	261	3/25/2005	EMF
375	298	3/27/2005	EMF
375	316	3/27/2005	EMF
455	110	3/27/2005	EMF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	3/25/2005	EMF
PALM INVENTORSHIP	3/25/2005	EMF
IEEE Keyword Search	3/25/2005	EMF